

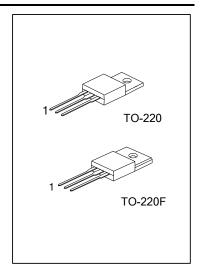
4N50 Preliminary Power MOSFET

4 Amps, 500 Volts N-CHANNEL POWER MOSFET

DESCRIPTION

The UTC **4N50** is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

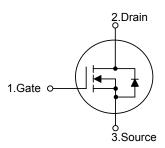
The UTC **4N50** is generally applied in high efficiency switch mode power supplies, active power factor correction and electronic lamp ballasts based on half bridge topology.



■ FEATURES

- * 4A, 500V, $R_{DS(ON)}$ =2.0 Ω @ V_{GS} =10V
- * High Switching Speed
- * 100% Avalanche Tested

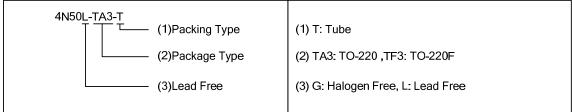
■ SYMBOL



■ ORDERING INFORMATION

Ordering Number		Doolsono	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
4N50L-TA3-T	4N50G-TA3-T	TO-220	G	D	S	Tube	
4N50L-TF3-T	4N50G-TF3-T	TO-220F	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



www.unisonic.com.tw 1 of 6

Downloaded from Elcodis.com electronic components distributor

■ **ABSOLUTE MAXIMUM RATINGS** (T_C=25°C, unless otherwise specified)

PARAMETER			SYMBOL	RATINGS	UNIT	
Drain-Source Voltage			V_{DSS}	500	V	
Gate-Source Voltage			V_{GSS}	±30	V	
Drain Current	Continuous (T _C =25°C)		I _D	4	Α	
	Pulsed (Note 1)		I _{DM}	16 *	Α	
Avalanche Current (Note 1)			I _{AR}	4	Α	
Avalanche Energy	Single Pulsed (Note 2)		E _{AS}	216	mJ	
	Repetitive (Note 3)		E _{AR}	8.5	mJ	
Peak Diode Recovery dv/dt (Note 3)			dv/dt	4.5	V/ns	
Power Dissipation	T -25°C	TO-220	P _D	85	W W/°C	
	T _C =25°C	TO-220F		28		
	Derate above 25°C	TO-220		0.67		
		TO-220F		0.22		
Junction Temperature			T_J	+150	°C	
Storage Temperature			T _{STG}	-55~+150	°C	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
lunction to Ambient	TO-220	— A	62.5	°C/W	
Junction to Ambient	TO-220F		62.5		
lunction to Coop	TO-220	θ _{JC}	1.47	°C/W	
Junction to Case	TO-220F		4.5		

^{*} Drain current limited by maximum junction temperature

■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise noted)

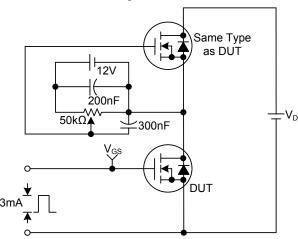
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage		BV_{DSS}	I _D =250μA, V _{GS} =0V	500			V		
Drain-Source Leakage Current		I _{DSS}	V _{DS} =500V, V _{GS} =0V			1	μΑ		
Gate- Source Leakage Current	Forward	1	V_{GS} =+30V, V_{DS} =0V			+100	nA		
	Reverse	I _{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	nA		
ON CHARACTERISTICS									
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$			4.0	V		
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =2A		1.65	2.0	Ω		
DYNAMIC PARAMETERS									
Input Capacitance	nput Capacitance				485	650	pF		
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		65	90	pF		
Reverse Transfer Capacitance		C_{RSS}			5	8	pF		
SWITCHING PARAMETERS									
Total Gate Charge		Q_{G}	V _{GS} =10V, V _{DS} =400V, I _D =4A		11	15	nC		
Gate to Source Charge		Q_{GS}	(Note 4, 5)		3		nC		
Gate to Drain Charge		Q_GD	(14010 4, 0)		5		nC		
Turn-ON Delay Time		$t_{D(ON)}$			14	38	ns		
Rise Time		t _R	V_{DD} =250V, I_{D} =4A, R_{G} =25 Ω		21	52	ns		
Turn-OFF Delay Time		t _{D(OFF)}	(Note 4, 5)		27	64	ns		
Fall-Time	-all-Time				20	50	ns		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS									
Maximum Body-Diode Continuous Current		Is				4	Α		
Maximum Body-Diode Pulsed Current		I _{SM}				16	Α		
Drain-Source Diode Forward Voltage		V_{SD}	I _S =4A, V _{GS} =0V			1.6	V		
Body Diode Reverse Recovery Time		t _{RR}	I _S =4A, V _{GS} =0V, dI _F /dt=100A/μs		36		ns		
Body Diode Reverse Recovery Charge		Q_{RR}	(Note 4)		33		μC		

Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

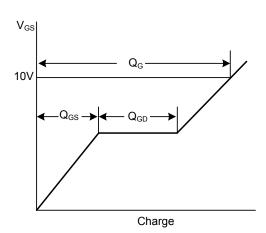
- 2. L = 27mH, I_{AS} = 4A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}C$
- 3. $I_{SD} \le 4A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%
- 5. Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

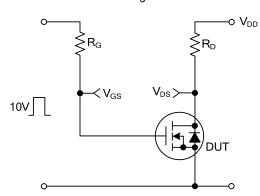
Gate Charge Test Circuit



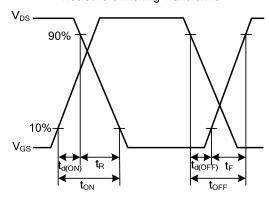
Gate Charge Waveforms



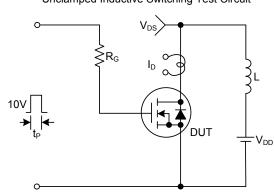
Resistive Switching Test Circuit



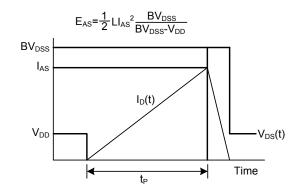
Resistive Switching Waveforms



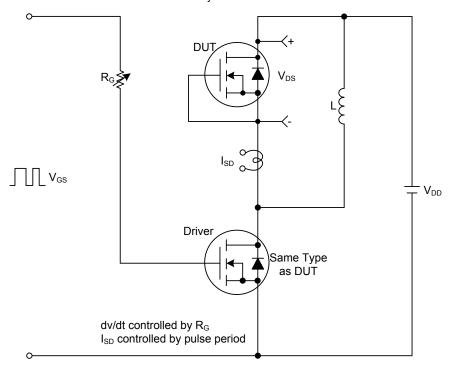
Unclamped Inductive Switching Test Circuit

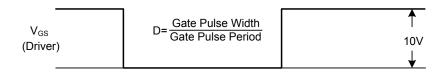


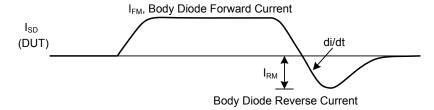
Unclamped Inductive Switching Waveforms

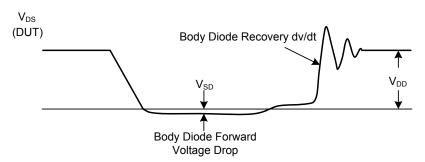


Peak Diode Recovery dv/dt Test Circuit & Waveforms









UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice.

